INTEGRATED CIRCUITS

DATA SHEET

PCK2002P 533 MHz PCI-X clock buffer

Product data Supersedes data of 2001 May 09 2002 Dec 13







533 MHz PCI-X clock buffer

PCK2002P

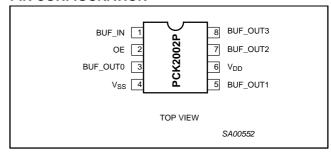
FEATURES

- General purpose and PCI-X 1:4 clock buffer
- 8-pin TSSOP package
- See PCK2001 for 48-pin 1:18 buffer part
- See PCK2001M for 28-pin 1:10 buffer part
- See PCK2001R for 16-pin 1:6 buffer part
- Operating frequency: 0 533 MHz
- Part-to-part skew < 500 ps
- Low output skew: <200 ps
- 3.3 V operation
- ESD classification testing is done to JEDEC Standard JESD22.
 Protection exceeds 2000 V to HBM per method A114.

DESCRIPTION

The PCK2002PL is a 1-4 fanout buffer used as a high-performance, low skew, general purpose and PCI-X clock buffer. It distributes one input clock (BUF_IN) signal to four output clocks (BUF_OUT_n).

PIN CONFIGURATION



PIN DESCRIPTION

PIN NUMBER	I/O TYPE	SYMBOL	FUNCTION
1	Input	BUF_IN	Buffered clock input
3, 5, 7, 8	Output	BUF_OUT (0-3)	Buffered clock outputs
6	Input	V_{DD}	3.3 V supply
2	2 Input		Output Enable
4	Input	V _{SS}	Ground

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t _{PLH} t _{PHL}	Propagation delay BUF_IN to BUF_OUT _n	V _{CC} = 3.3 V, C _L = 25 pF	2.9 2.8	ns
t _r	Rise time	$V_{CC} = 3.3 \text{ V}, C_L = 25 \text{ pF}, 0.2 V_{DD} \text{ to } 0.6 V_{DD}$	800	ps
t _f	Fall time	$V_{CC} = 3.3 \text{ V}, C_L = 25 \text{ pF}, 0.6 V_{DD} \text{ to } 0.2 V_{DD}$	600	ps
I _{CC}	Total supply current	V _{CC} = 3.6 V	50	μΑ

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	ORDER CODE	DRAWING NUMBER
8-Pin Plastic TSSOP	-40 to +85 °C	PCK2002PDP	SOT505-1
8-Pin Plastic SO	-40 to +85 °C	PCK2002PD	SOT96-1

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FUNCTION TABLE

OE	BUF_IN	BUF_OUTn
L	X	L
Н	L	L
Н	Н	Н

ABSOLUTE MAXIMUM RATINGS^{1, 2}

In accordance with the Absolute Maximum Rating System (IEC 134). Voltages are referenced to V_{SS} ($V_{SS} = 0 V$).

SYMBOL	PARAMETER	CONDITION	LII	UNIT	
STWBOL	PARAMETER	CONDITION	MIN	MAX	UNII
V_{DD}	DC 3.3 V supply voltage		-0.5	+4.3	V
I _{IK}	DC input diode current	V ₁ < 0	_	-50	mA
VI	DC input voltage	Note 2	-0.5	V _{DD} + 0.5	V
I _{OK}	DC output diode current	$V_O > V_{DD}$ or $V_O < 0$	_	±50	mA
Vo	DC output voltage	Note 2	-0.5	V _{DD} + 0.5	V
Io	DC output source or sink current	$V_O \ge 0$ to V_{DD}	_	±50	mA
T _{stg}	Storage temperature range		-65	+150	°C
P _{tot}	Power dissipation per package plastic medium-shrink SO (SSOP)	For temperature range: 0 to +70 °C above +55 °C derate linearly with 11.3 mW/K	_	850	mW

NOTES:

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	LIM	UNIT	
STWIBUL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
V_{DD}	DC 3.3V supply voltage		3.0	3.6	V
C _L	Capacitive load		20	30	pF
VI	DC input voltage range		0	V_{DD}	V
Vo	DC output voltage range		0	V_{DD}	V
T _{amb}	Operating ambient temperature range in free air		-40	+85	°C

^{1.} Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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DC CHARACTERISTICS

			TEST CONDITIONS		LIM	ITS	
SYMBOL	PARAMETER		TEST CONDITIONS	T _{amb} = -40	UNIT		
		V _{DD} (V)	V _{DD} (V) OTHER		MIN	MAX	
V_{IH}	HIGH level input voltage	3.0 to 3.6	_	_	2.0	$V_{DD} + 0.3$	V
V_{IL}	LOW level input voltage	3.0 to 3.6	_	_	V _{SS} - 0.3	0.8	V
		3.0 to 3.6	I _{OH} = -1 mA	_	V _{DD} - 0.2	_	V
V _{OH}	Output HIGH voltage	3.0	I _{OH} = -24 mA	_	2.0	_	V
		3.0	I _{OH} = -12 mA	_	2.4	_	V
		3.0 to 3.6	I _{OL} = 1 mA	_	_	0.2	V
V_{OL}	Output LOW voltage	3.0	I _{OL} = 24 mA	_	_	0.8	V
		3.0	I _{OL} = 12 mA	_	_	0.55	V
	Outset HIGH sumset	3.0	V _{OUT} = 1 V	_	-50	_	mA
Іон	Output HIGH current	3.3	V _{OUT} = 1.65 V	_	_	-150	mA
	Output LOW suggest	3.0	V _{OUT} = 2.0 V	_	60	_	mA
l _{OL}	Output LOW current	3.3	V _{OUT} = 1.65 V	_	_	150	mA
±l _l	Input leakage current	eakage current $3.6 V_I = V_{DD} { or GND } -$		_	_	±5	μΑ
Icc	Quiescent supply current	3.6	$V_I = V_{DD}$ or GND $I_O = 0$		_	100	μΑ

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AC CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDI	TIONS	T _{am}	UNIT		
			NOTES	MIN	TYP ⁶	MAX	
t _H	CLK HIGH time	66 MHz	2	6.0	_	_	ns
t∟	CLK LOW time	00 IVITIZ	3	6.0	_	_	ns
t _H	CLK HIGH time	140 MHz	2	2.9	_	_	ns
t∟	CLK LOW time	140 IVITZ	3	3.0	_	_	ns
t _R	Output rise slew rate		4	1.4	1.7	4.0	V/ns
t _F	Output fall slew rate		4	1.5	2.2	4.0	V/ns
t _{PLH}	Buffer LH propagation delay		5	1.8	2.9	3.4	ns
t _{PHL}	Buffer HL propagation delay		5	1.8	2.8	3.4	ns
tskw	Bus CLK skew		1		_	200	ps
t _{DDSKW}	Device to device skew		1	_	_	500	ps

NOTES:

- 1. CLK skew is only valid for equal loading of all outputs.
- 2. t_{H} is measured at 0.5 V_{DD} as shown in Figure 2.
- 3. t_L is measured at 0.35 V_{DD} as shown in Figure 2.
- 4. t_R and t_F are measured as a transition through the threshold region 0.2 V_{DD} to 0.6 V_{DD} and 0.6 V_{DD} to 0.2 V_{DD}.
 5. Input edge rate for these tests must be faster than 1 V/ns.
- 6. All typical values are at $V_{CC} = 3.3 \text{ V}$ and $T_{amb} = 25 \,^{\circ}\text{C}$.

AC WAVEFORMS

 $V_M = 50\% V_{DD}$ $C_{L}^{(v)} = 25 \text{ pF}$

 V_{OL}^- and V_{OH} are the typical output voltage drop that occur with the

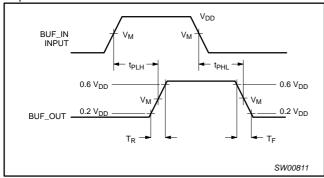


Figure 1. Load circuitry for switching times.

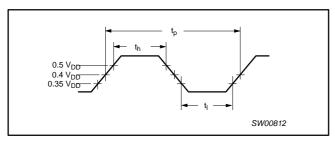


Figure 2. Buffer Output clock

TEST CIRCUIT

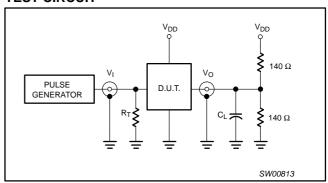


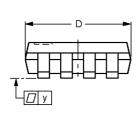
Figure 3. Load circuitry for switching times

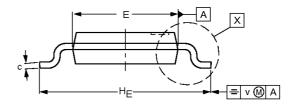
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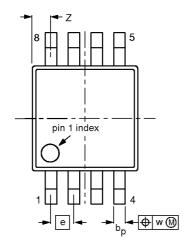
PCK2002P

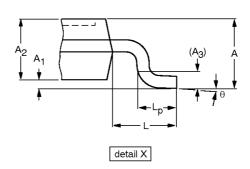
TSSOP8: plastic thin shrink small outline package; 8 leads; body width 3 mm

SOT505-1











DIMENSIONS (mm are the original dimensions)

u	NIT	A max.	A ₁	A ₂	А3	bр	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lр	v	w	у	Z ⁽¹⁾	θ
r	mm	1.10	0.15 0.05	0.95 0.80	0.25	0.45 0.25	0.28 0.15	3.10 2.90	3.10 2.90	0.65	5.10 4.70	0.94	0.70 0.40	0.1	0.1	0.1	0.70 0.35	6° 0°

Notes

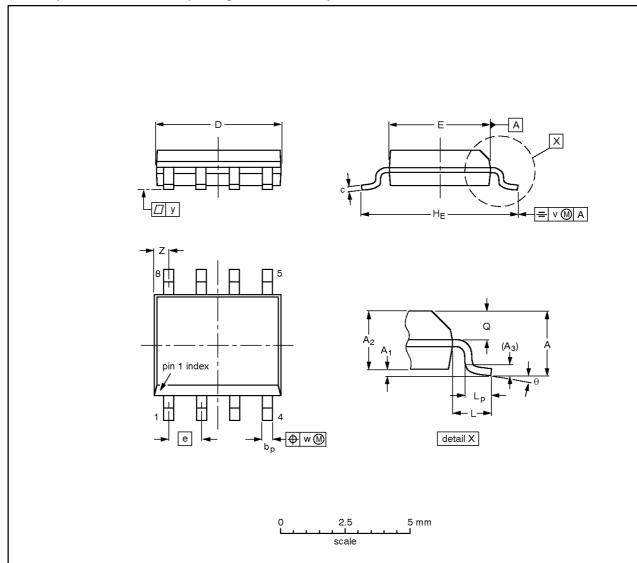
- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	IEC JEDEC EIAJ			PROJECTION	ISSUE DATE	
SOT505-1						99-04-09	

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SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.20 0.19	0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT96-1	076E03	MS-012		₩	97-05-22 99-12-27	

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REVISION HISTORY

Rev	Date	Description	
_3	20021213	Product data (9397 750 10863); ECN 853-2254 29225 of 22 November 2002	
		Modifications:	
		● Increase F _{max} to 533 MHz.	
_2	20010509	Product data (9397 750 08348); ECN 853-2254 26252 of 09 May 2001.	

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Level	Data sheet status ^[1]	Product status ^[2] [3]	Definitions
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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